

<b>Notice of References Cited</b>	Application/Control No. 10/717,502	Applicant(s)/Patent Under Reexamination MIYAKAWA ET AL.	
	Examiner Mark Eashoo, Ph.D.	Art Unit 1732	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,552,351	09-1996	Anderson et al.	501/81
*	B	US-4,486,934	12-1984	Reed, James R.	76/107.1
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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